

Notice of References Cited	Application/Control No. 10/798,577	Applicant(s)/Patent Under Reexamination LEE ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,387,314	02-1995	Baughman et al.	216/27
	B	US-4,882,595	11-1989	Trueba et al.	347/85
	C	US-5,308,442	05-1994	Taub et al.	216/27
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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